

The Need for Large-Scale Biometric Testing

Patrick Grother

Information Access Division

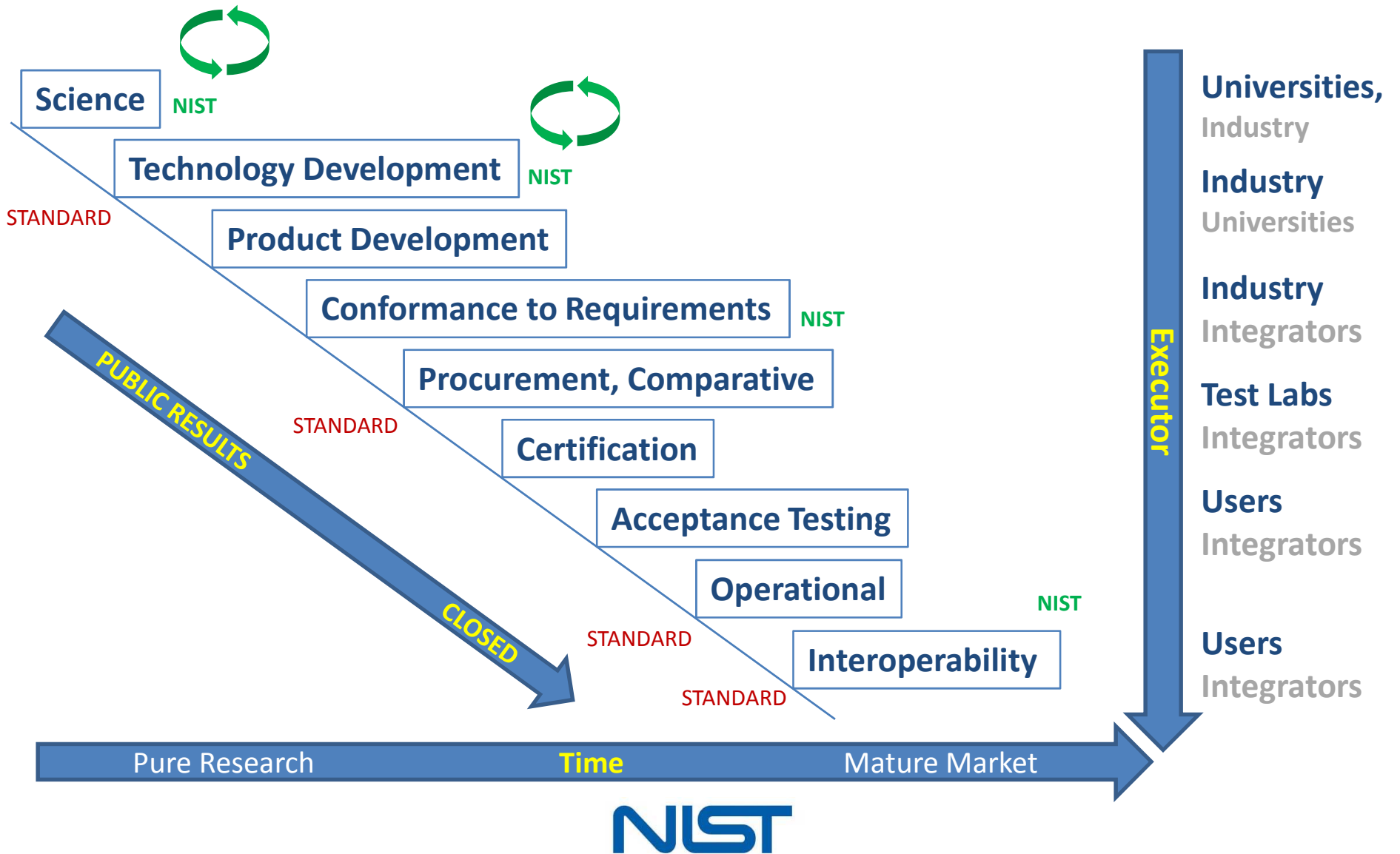
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The purposes of biometric testing

- » Scientific discovery
 - » Basic research, sensors, algorithms,
- » Research and development
 - » Is the method better than before?
 - » Internal commercial, or gov-industry cooperation
- » Capability testing
 - » Is the technology viable?
 - Benchmarking
 - Core capability
 - » Establishing criteria
- » Testing to know what's possible
 - » Could requirements be met
 - » Is the technology viable?
- » Comparative testing
 - » Which technology?
 - » Which implementation?
- » Conformance
 - » To requirements
 - » To standards
- » Interoperability testing
 - » Can we upgrade, replace, while keeping our data?
 - » Jurisdictional interoperability
- » Certification
 - » Can we leverage others' tests?
- » Regression
 - » Has the update helped?

Stages of Testing



Why test at all?

» It's about money

» Biometric errors cause additional cost

- Failure to enroll → additional time, procedures, modalities, processes, time
- In 1:N false non-match → benefits fraud, immigration fraud
- In 1:N false match → identity resolution processes

» Can the application requirements be met?

» Can the technical requirements be met?

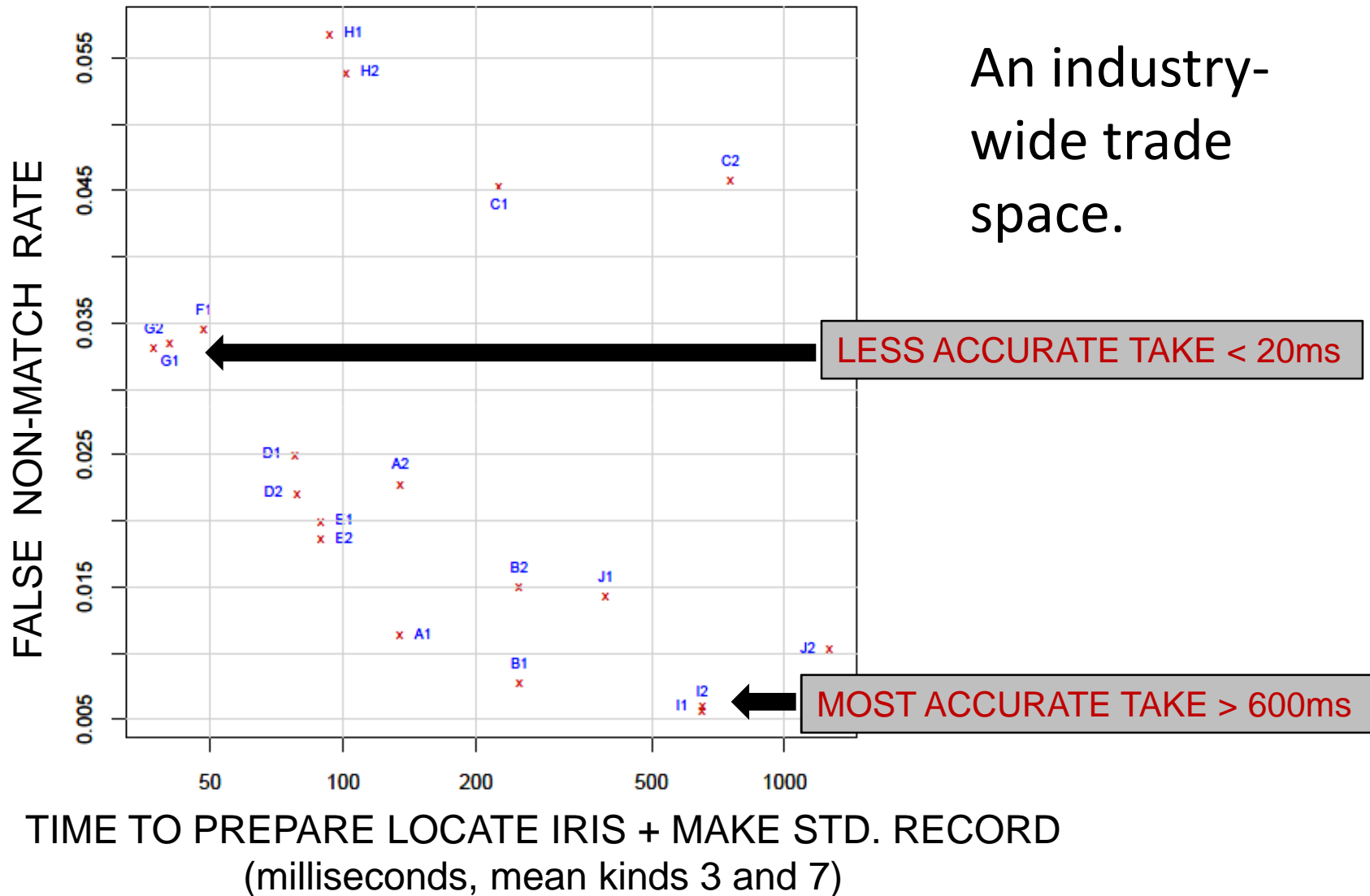
» Risk mitigation

- Characterizing performance allows procedures to mitigate risk e.g. a finding that FTE > 0.03 prompts environmental redesign to regulate humidity, or ambient light.

» Conformance, Interoperability

- Entire system needs to be upgraded / junked if it doesn't interoperate with others

Trading Time for Accuracy

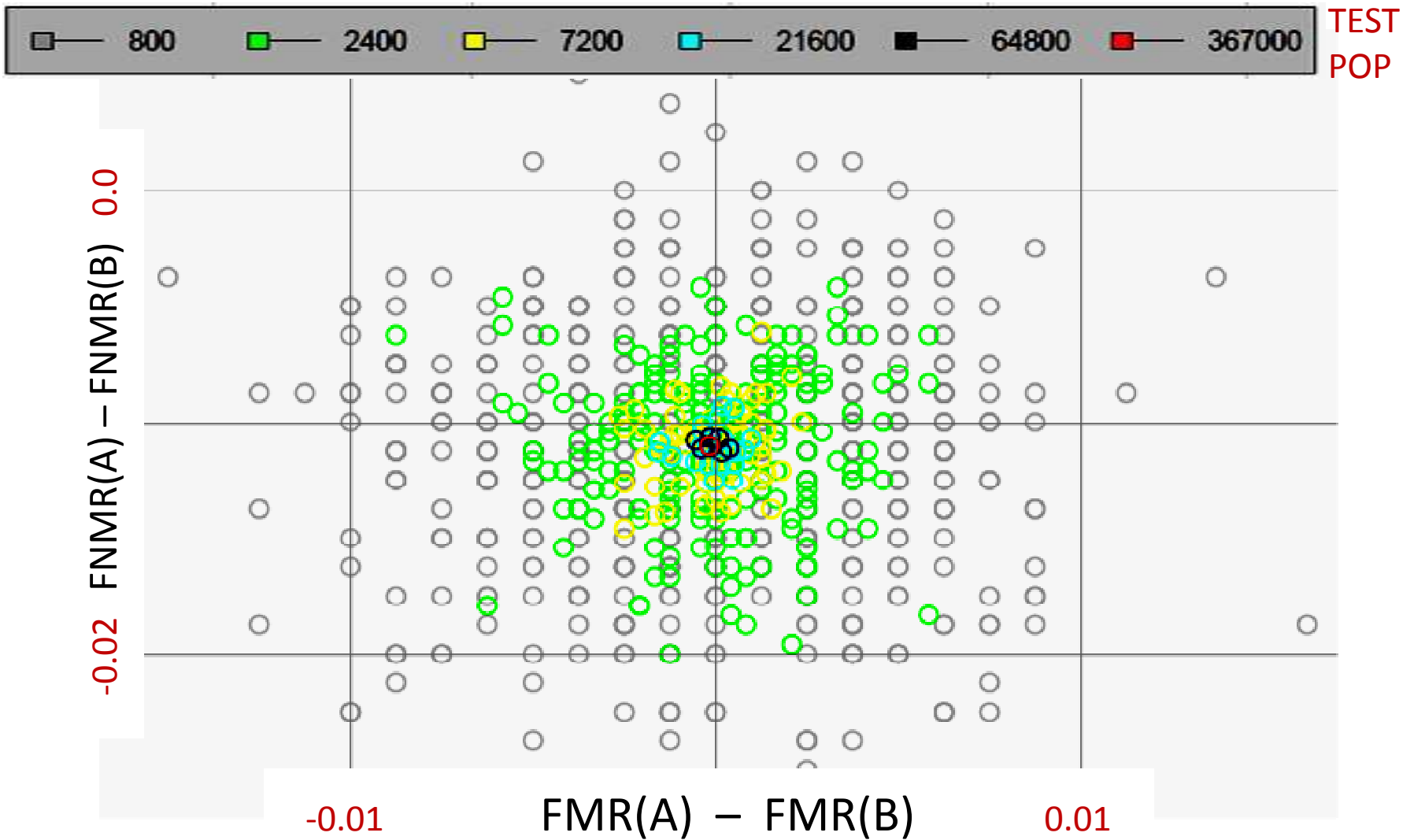


An industry-wide trade space.

Large scale testing, eh? What's large?

- » Statistical definition of large
 - » Depends on purpose
 - e.g. show, with 99% confidence, that a match-on-card comparison algorithm has FAR < 10⁻⁴
 - e.g. existence proof that a gummy finger can be enrolled in a biometric system
 - e.g. given a choice of instructional modes for use of a biometric sensor, determine via live test, which is best
 - e.g. testing whether a e-Passport conformance testing suite correctly rejects defective records or JPEG 2000 streams
 - » Technology dependent
 - e.g. comparing AFIS systems vs. comparing 1:1 ePassport gates
- » Practically...
 - » Systematic effects are larger than random effects and these can be identified efficiently
 - Irises with radius greater than 150 pixels always fail to enroll
 - » Cost constraints limit population size, test duration
 - Corners are cut (e.g. full-cross comparison of N samples)
 - » Test crews get tired

Test Size :: Vendor A vs. B



IBPC 2010

» International Biometric Performance Conference

- » Novel test methods, metrics
- » Specification, requirements, certification
- » Accuracy, security, operational
- » Emphasis on **how** systems are tested, vs. latest results



Homeland
Security

» Co-chairs

- » Patrick Grother, Elham Tabassi, NIST
- » Christoph Busch, Fraunhofer
- » Tony Mansfield, NPL



» Logistics

- » March 2-4, 2010
- » Gaithersburg, Maryland
- » Call for papers: <http://biometrics.nist.gov/ibpc2010>

NIST



In 119 pages IREX covers

- » <http://iris.nist.gov/irex>
- » Compare algorithmic accuracy
 - » ROCs
 - » Fixed threshold – effect on FMR and FNMR
- » Speed-accuracy trade-space
- » False Match Rate Calibration
 - » How to set the threshold
- » Effect of dataset
 - » On FNMR, on FMR
- » Algorithm interoperability
 - » Enroll on A – Identify on B
 - » Segmentation performance
- » Image quality assessments
- » Biometric zoo
- » Compare lossy compression algs
 - » JPEG vs. JPEG 2000
- » Limits of lossless compression
- » Bounds on iris size
- » How closely to crop an iris
- » Comparison of specialized formats
 - » Masked vs. Polar
 - » Which is fit for purpose
- » Effect of pupil dilation
 - » And change in dilation
- » Effect of eyelid occlusion
- » Effect of iris-pupil displacement

Thanks
patrick.grother@nist.gov

301 975 4157

Minutia interoperability: <http://fingerprint.nist.gov/minex>

Iris interoperability: <http://iris.nist.gov/irex>

Biometric Performance Conference: <http://biometrics.nist.gov/ibpc2010>

